



CHENMKO ENTERPRISE CO.,LTD

Halogens free devices

SURFACE MOUNT

SCHOTTKY BARRIER DIODE

VOLTAGE 40 Volts CURRENT 0.04 Ampere

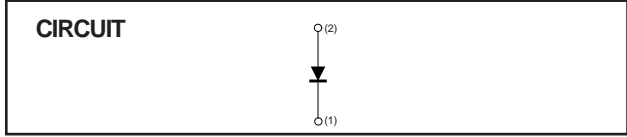
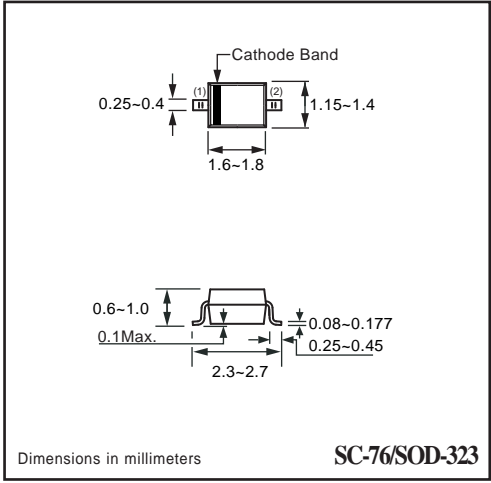
CH740H-40GP

APPLICATION
 * Low barrier diode for detectors up to GHz frequencies

FEATURE
 * Small surface mounting type. (SC-76/SOD-323)
 * Low VF and low IR
 * High reliability

CONSTRUCTION
 * Silicon epitaxial planar

MARKING
 * JC



MAXIMUM RATINGS (At TA = 25°C unless otherwise noted)

RATINGS	SYMBOL	CH740H-40GP			UNITS
		MIN.	TYP.	MAX.	
Maximum Recurrent Peak Reverse Voltage	VRRM	-	-	40	Volts
Maximum Average Forward Rectified Current	Io	-	-	40	mAmps
Total Power Dissipation, Ts< 85 °C	PTOT	-	-	150	mW
Typical Series Inductance	Ls	-	1.8	-	nH
Typical Case Capacitance	Cc	-	0.1	-	pF
Typical Junction Capacitance between Terminal (Note 1)	CJ	-	0.35	0.6	pF
Typical Differential Resistance (Note 2)	Ro	-	225	-	kΩ
Operating and Storage Temperature Range	TJ,TSTG	-55	-	+150	°C

ELECTRICAL CHARACTERISTICS (At TA = 25°C unless otherwise noted)

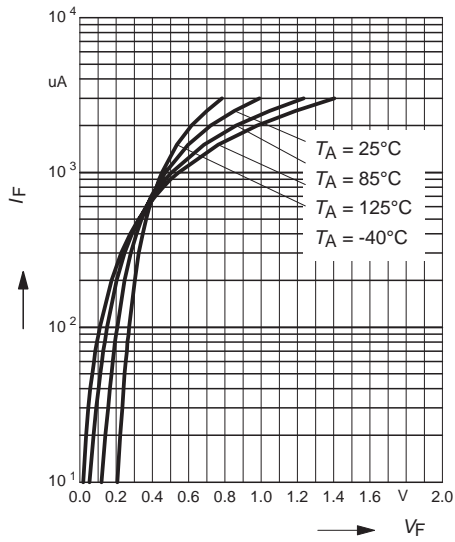
CHARACTERISTICS	SYMBOL	CH740H-40GP			UNITS
		MIN.	TYP.	MAX.	
Maximum Instantaneous Forward Voltage at If= 2mA	VF	-	0.58	1.00	Volts
Maximum Average Reverse Current at VR= 40V	IR	-	-	10	uAmps

NOTES : 1. Measured at 1.0 MHz and applied reverse voltage of 0 volts.
 2. Measured at 1.0 KHz and applied reverse voltage of 0 volts.
 2. ESD sensitive product handling required.

RATING CHARACTERISTIC CURVES (CH740H-40PT)

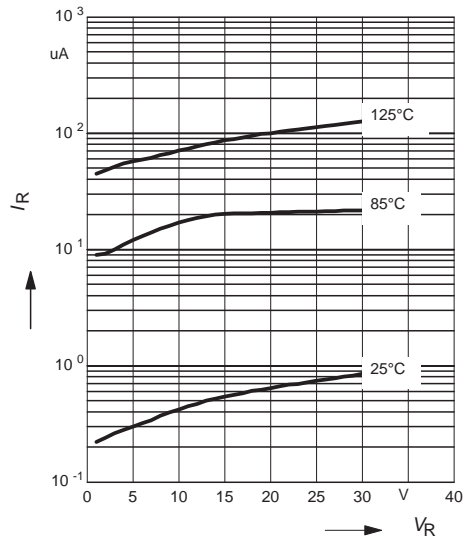
Forward current $I_F = f(V_F)$

$T_A = \text{parameter}$



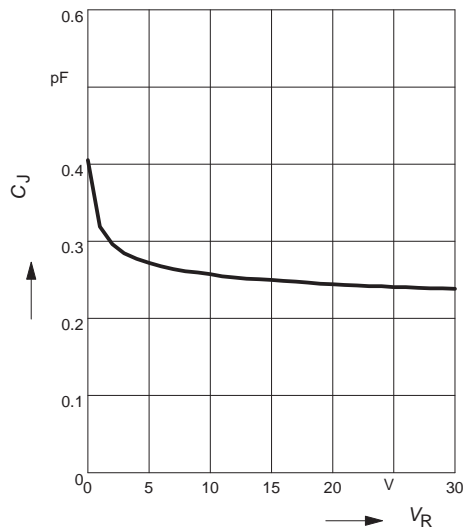
Leakage current $I_R = f(V_R)$

$T_A = \text{Parameter}$



Diode capacitance $C_J = f(V_R)$

$f = 1\text{MHz}$



Rectifier voltage $V_A = f(V_E)$

$f = 900\text{ MHz}$

$R_L = \text{parameter in } \Omega$

